

Notice of References Cited

Application/Control No.

10/642,386

Applicant(s)/Patent Under
Reexamination
WANG ET AL.

Examiner

ALEX NOGUEROLA

Art Unit

1753

Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,621,263	09-2003	Al-Janabi et al.	324/200
*	B	US-6,884,333	04-2005	Landau, Uziel	205/81
*	C	US-5,217,112	06-1993	Almon, Amy C.	205/794.5
*	D	US-4,172,777	10-1979	Yamamoto et al.	204/406
*	E	US-6,187,164	02-2001	Warren et al.	205/81
*	F	US-6,251,245	06-2001	Satsutani et al.	204/416
*	G	US-5,445,726	08-1995	Cammann, Karl	205/780.5
*	H	US-4,166,020	08-1979	Trampert, Hans R.	204/416
*	I	US-6,106,692	08-2000	Kunimatsu et al.	205/775
*	J	US-4,863,572	09-1989	Jasinski, Raymond J.	205/775.5
*	K	US-4,696,103	09-1987	Behl et al.	29/825
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Yabe et al. ("Rotating Ring Disk Electrode in Molten Chloride," Electrochimica Acta, Vol. 34, No. 10, pp. 1479-1483, 1989)
	V	Strycker et al. ("Development of a platinum rotating disc electrode for dynamic electrochemical measurements in glass melts," Journal of Non-Crystalline solids 289 (2001) 106-112)
	W	Stojanovic et al. ("Development of a rotating ring-disc electrode for high temperature studies in cryolite-based melts," journal of Applied Electrochemistry 25 91995) 456-461)
	X	Ito et al. ("Rotating Ring Disk Electrode in Molten Chloride Systems," Materials Science Forum vol. 73 - 75 (1991) pp. 409-414)

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Alex Noguera
3/21/07

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Page 2 of 3

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Derwent abstract of Kunimatsu et al. (US 6,106,692). August 22, 2000
	V	"coating" definition from Webster's Third New International Dictionary, unabridged. 1993.
	W	Chemical Elements.com – Molybdenum downloaded from www.chemicalelements.com on March 20, 2007
	X	Chemical Elements.com – Gold downloaded from www.chemicalelements.com on March 20, 2007

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Page 3 of 3

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	M	US-			

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Chart of COE's Coefficient of Thermal Expansion" from www.lucasmilpaupt.com on March 21, 2007),
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.